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The requirements of a microscope differ greatly from field to field and with the sample being studied. Organic thin films are highly sensitive to environmental conditions being rapidly photobleached in the presence of oxygen. In this paper we introduce the design of a low cost near field optical microscope suitable for environmentally controlled studies. We demonstrate that reducing ambient pressure to ~10 mTorr (1.3 Pa) of nitrogen (a pressure accessible with a mechanical pump) significantly reduces photo-bleaching on a typical experimental timescale. In addition, we introduce a novel non-optical feedback control mechanism combining a piezoelectric diaphragm with a tuning fork. The morphology of thin films of MEH-PPV spin cast from the polymer dissolved in chlorobenzene is investigated. These films are shown to be featureless on a 100 nm length scale in terms of topology, PL intensity and PL spectrum both before and during photo-bleaching. As far as we are aware these are the first reported thin films of MEH-PPV grown in which ~100 nm sized domains are absent. We believe that the ability to control environment will not only allow better optical characterization of thin films but also opens up the possibility of the production of novel two dimensional organic photonic crystals through a combination of mechanical disruption, photo-bleaching and photo-conjugation of polymers.

Keywords: Near field optical microscopy; MEH-PPV; Organic thin films; Luminescent conjugated polymer; Controlled environment; Shear-force feedback.

INTRODUCTION

The performance of luminescent conjugated polymer light emitting devices (PLEDs) is largely determined by sample preparation. Seemingly minor modifications in processing have been observed to have a profound effect on both the resulting films’ optical properties\(^2\) and charge transport (i.e. hole mobility) characteristics.\(^3\) Paradoxically, charge carrier mobility has been reported to vary greatly in films of MEH-PPV (a soluble derivative of poly(phenylenevinylene) having identical (far-field) photoluminescence (PL) spectra.\(^4\) This suggests that local morphology, in terms of sub-micron domains, may play an important role in charge transport and photo-physics.

Efforts have been made to correlate PL and topography on the nanometer scale making use of near-field scanning optical microscopy (NSOM) and shear force microscopy. In thin films of MEH-PPV, Nguyen and coworkers\(^5\) observed that topographic features (bumps) and local PL spectra were generally correlated for thin films of MEH-PPV which had been prepared from polymer dissolved in chlorobenzene (CB) and tetrahydrofuran (THF). A similar set of experiments performed by Huser and coworkers\(^6\) with toluene as the solvent did not find any correlation between topography and PL intensity variations. In both
cases, the characteristic feature size was ~20 nm in height and a few hundreds of nanometers in diameter.

A difficulty faced in such studies is that organic films are very sensitive to atmospheric oxygen and light. Although quite stable when kept in the dark or in a nitrogen environment, rapid photo-oxidation or photo-bleaching occurs on continuous excitation under atmospheric conditions. Local spectroscopic experiments are thus not repeatable (i.e., the measurement modifies the film). While nitrogen purging offers some improvement, it is generally not sufficient to allow for an extensive investigation of observed features. In confocal microscopy photo-bleaching is reduced by depositing a protective layer of aluminum on top of the film being studied. This is clearly not possible for NSOM as the tip must approach the film surface. Our earlier measurements from time-of-flight (TOF) have shown that the MEH-PPV is stable under dynamic vacuum suggesting that operating a NSOM under a controlled environment may solve these problems.

The idea of operating a NSOM under non-atmospheric conditions is not a new idea. For example, in 1999 Gray and Hsu reported on their development of a variable cryogenic temperature near-field scanning optical microscope. In 2005, the development of a reflection mode NSOM capable of operation in an ultrahigh vacuum environment was reported. Clearly the application for which a microscope is to be used will determine its design. While the physical studies for which the above microscopes were designed require that they operate under extreme conditions (e.g., ultra-high vacuum, cryogenic temperatures), less stringent requirements in terms of expense, apply to studies of organic thin films. In particular, for thin film studies one must be able to:

– control and vary the pressure in a range from mTorr to atmosphere,
– control and vary the partial pressures of the sample environment,
– excite a limited region of the sample (i.e., illumination not collection mode),
– collect photo-luminescence at a high signal to noise ratio (i.e., high numerical aperture collection optics).

In this paper we discuss the development of a controlled environment near-field scanning optical microscope that meets these requirements. In addition, the design is simple, relatively low-cost, and user-friendly (in terms of facilitating relatively easy changing of the optical fiber). The microscope is applied to a study of MEH-PPV thin films produced using the solvent chlorobenzene. In contrast to previously reports regarding thin films of MEH-PPV, these films are topologically featureless, exhibiting identical PL intensity and PL spectrum across the surface.

The placing of the NSOM in a controlled environment is shown to significantly reduce photo-bleaching on the experimental time scale. However, the soft organic films are shown to be susceptible to mechanical damage. The latter effect may be useful in patterning of the conjugated substrate.

MICROSCOPE DESIGN

A picture of the microscope is shown in Fig. 1. The design of the microscope is comprised of three sub-systems, namely, mechanical and vacuum system, optical system, and a novel non-optical feedback control mechanism to monitor tip-sample separation. These three systems will be discussed separately.

1. Mechanical Hardware

A schematic of the mechanical system is shown in Fig. 2. The environmental chamber (17 cm × 17 cm × 21 cm high) was composed of an Al base (13 mm thick) and a removable Perspex (Lucite) cover (20 mm thick). A single O-Ring (3 mm in diameter) inserted into a groove machined in the Al base seals the junction between the base and cover. The metal base had five vacuum sealed feed-

![Fig. 1. Picture of the environmentally controlled near field optical microscope. (left) Front view (right) Side view.](image-url)
throughs and one glass window. Two feedthroughs (Souriau) were used for electrical connections. Two feedthroughs – one connected to a gas supply and the other to a low cost mechanical vacuum pump – allow the environment and pressure within the chamber to be controlled dynamically. The transparent cover allowed the approach of the tip to be monitored by a microscope placed outside the chamber. Plastic tubes (instead of metal) were used in order to minimize the transmission of vibration from the mechanical pump to the chamber. In the case of the experiments being described here, the gas supply port was connected to a dry nitrogen cylinder. Before observations, the chamber was evacuated to 10 mTorr and flushed repeatedly with the dry nitrogen gas to remove any residual oxygen. Experiments were then performed after keeping the vacuum running for few hours. The remaining feedthrough was used for an optical fiber to couple light into the system.

Position control was accomplished using a combination of manual and motor mechanisms mounted on the metal base inside the chamber. A small actuator drive stage with large horizontal displacement (New Focus Picomotor Actuator-translation stage-9065) was used to position the sample to allow various regions to be scanned. For vertical movement, a translation stage with both manual and DC motor capability (New Focus Picomotor Actuator-translation stage 9065) was used to approach the tip to the sample. Before closing the system, the manual part was used to approach the tip to within few hundreds μm of the sample. Once the environmental conditions at which the experiment was to be conducted had been reached, the actuator is used to bring the tip to within 50 μm of the sample. An additional piezoelectric driven stage (Melles Griot, 50 μm Piezo range) was used to bring the sample and tip into shear force range. Actual three-dimensional scanning of the tip over the sample was performed using a segmented piezoelectric tube (Stavely Sensors, EBL piezoceramic tube, length = 0.5”, outside diameter = 0.25”, width = 0.02”).

A total of fifteen electronic ports (grouped into two feedthroughs) were used to connect wires from inside to outside the chamber. Five wires were used to control the segmented piezoelectric tube (1 for each of the 4 segments + 1 ground). Two wires were used to vary the sample regions to be scanned. Four wires were used to control the DC motor (New Focus) and piezo-electric adjustable stage (Melles Griot) used for the final approach of the tip to the sample surface. The remaining four wires were used to implement the tip-sample control system.

The above mechanical system allowed for the environmental control and both high and low pressure operation. In addition, all electrical components can be shut off as the chamber is filled and flushed with nitrogen. This is important since a short circuit may develop between the high-voltage applied to the segmented piezoelectric tube and the tuning fork. (At atmospheric pressure gases are insulators. The few existing free charges collide with neutral molecules before gaining sufficient energy from the electric field to ionize them. However, as the pressure is lowered, the mean free path of free charges (inversely proportional to the number density of gas molecules) increases and the free charges acquire sufficient energy from the electric field to ionize other molecules resulting in electrical breakdown. As pressure is furthered lowered (below 100 mTorr, 10 Pa), the mean free path exceeds the electrode separation (i.e. between the segmented piezoelectric tube and the tuning fork) and the free charges rarely collide with gas molecules. Electrical breakdown thus does not occur and the high voltage components can be turned on again.)

We note that operation in a sealed environment also allows for the elimination of air currents resulting in increased topographic resolution as has been previously observed.

2. Optical System

Three kinds of light pass freely through the chamber:
the visible light that allows the sample and tip to be seen using a conventional microscope, the laser light used to excite the sample, and the photoluminescence emitted by the sample. The use of a Perspex cover allowed the sample to be clearly seen with visible light. Fig. 3 illustrates the optical paths of the excitation light and the emitted photoluminescence both inside and outside of the chamber. Laser light was first coupled into a commercial fiber and a commercial fiber optic vacuum pressure feed-through (OZ Optics) was used to couple the fiber into the vacuum chamber. A fiber coupler (Thorlabs) transferred light into a short section of chemically etched and aluminum coated fiber used for the tip. This allows mounted fiber tips to be easily replaced. Light passing through or emitted from the sample (substrate + holder thickness = 3 mm), after passing through a window (2 mm thick, Fig. 2), was collected from the bottom of the vacuum chamber using a long working distance (LWD) objective lens (M-40X, Nikon, N.A. 0.5, working distance 10.1 mm). The 10.1 mm long working distance is sufficient to allow focusing on the fiber tip. We note that while it is possible to place an objective lens inside the environment chamber, experience has shown that repeated cycling from high to low pressure greatly reduces the lifetime of the objective. A beam splitter directs some of the light into a CCD for alignment while the remaining light was directed into either a PMT (Hamamatsu R1104P) or monochromator/CCD (Santa Barbara Instrument Group ST-7Ei) for PL emission analysis. In the work described here, an air-cooled Ar-ion laser (Ion laser technology, $\lambda = 488$ nm) was coupled into the fiber. For PL detection, a 488 nm notch filter and a band pass filter were placed before the PMT. After taking a topographical and optical image, a few points on the sample surface were selected to record the local PL spectra. Tips were prepared by chemical etching followed by Al-coating rather than the conventional pulling technique as the chemical etching technique allows for a larger apex angle at the tip. (A larger apex angle allows for better feedback stability and greater optical throughput. 

3. Tip-sample separation control

A vital part of the NSOM system is the control of sample-tip separation. In most experiments, a NSOM is operated in constant separation mode using the so called “shear force” to provide information on the tip-sample separation. This has the additional advantage of allowing a topographical image to be obtained simultaneously with the optical image. Generally this is accomplished by vibrating the fiber (using a piezo-electric material) and monitoring the resonance frequency of the fiber as it approaches the surface. A number of techniques have been proposed to monitor this change in resonance frequency. The first method applied in NSOM involves direct optical monitoring of the tip. While possible, collection of the diffracted light is somewhat troublesome when the NSOM is placed inside a chamber. Non-optical methods are much more convenient in this situation. The most common non-optical method involves exciting a tuning fork at its resonance frequency using a piezo-electric tube and then monitoring the vibration of the fiber tip. Unfortunately, replacing the fiber tip assembly is not a simple procedure. An alternative method, involving a single piezo-electric diaphragm or bimorph for both excitation and detection, has been proposed for shear force sensing. In this work, we employ a hybrid of the two technologies in which a piezoelectric tuning fork is attached to a piezoelectric diaphragm for significantly greater ease of mounting. As shown in Fig. 4(a), the optical fiber is glued onto a tuning fork which is in turn affixed vertically onto the piezoelectric diaphragm. As shown in Fig. 4(b), two wires are used for driving the piezoelectric diaphragm which in turn drives the piezoelectric tuning fork at its resonance frequency. The two wires attached to the tuning fork detect changes in the piezotension-induced...
voltage as the tip approaches the surface. The signal was fed into the lock-in amplifier along with the original exciting sinusoid. The lock-in amplifier output was then fed into a computer which controlled the vertical position of the fiber (Fig. 2). Two screws allow the whole assembly to be firmly mounted on, and easily demounted from, the end of the piezoelectric tube. The Q of the whole assembly (with tip) was 200-400.

MICROSCOPE CHARACTERIZATION

1. Sample Preparation
Poly(2-methoxy-5-(2’-ethylhexyloxy)-1,4-phenylenevinylene) (MEH-PPV) was synthesized via the Gilch method following in general the procedure reported by Wudl and coworkers. The resulting polymer (M_w ~ 250 kD, poly-dispersity δ = 6.5 as obtained from Gel permeation chromatography (GPC) measurements) had a tetrahedral defect density of ~ 2% as obtained from NMR measurements. MEH-PPV was dissolved for several weeks in chlorobenzene. During this process, the solution was kept in a dark, inert nitrogen atmosphere. The polymer solution was taken out of the nitrogen box and spin-cast onto pre-cleaned glass slides to form a 60 nm thick MEH-PPV thin film (as measured by a Dektak 3030 Surface Profiler). The spin-coated film was then placed in an inert atmosphere for six hours. The remaining solvent, along with any adsorbed oxygen, was removed by storing in high vacuum for 12 hours. Throughout processing, neither the solution nor film temperature was raised above room temperature.

2. Photo-bleaching
The key purpose for designing this microscope is to allow experiments to be performed, i.e. spectra taken, reproducibly without worrying about photobleaching. Fig. 5 compares the PL intensity as a function of time for an MEH-PPV film in air and under low pressure dynamic vacuum (~10 mTorr nitrogen). The measurements are taken at low power in the far field to eliminate any effect due to probe-sample interaction. As seen in the figure, the PL intensity drops rapidly for the exposed film dropping to 80% within the first 50 s. In contrast, under dynamic vacuum, the intensity remains above 97% for over two minutes, only dropping to the 80% level after 5 minutes of continuous excitation. Assuming five seconds are required to take a spectrum with a moderate quality spectrometer, it is clear that the problem of photo-bleaching has been overcome on an experimental time scale.

3. Probe effects
Fig. 6 highlights the decay in the integrated PL inten-

Fig. 4. Schematic of the combination piezoelectric tuning fork and piezoelectric diaphragm used for reliable control of the sample-probe separation. (a) Side view (oscillation direction is in the plane of the page) (b) Front view showing the electrical connections.

Fig. 5. Comparison of the time evolution of PL intensity under atmospheric conditions (lower trace) with that under low pressure (~10 mTorr nitrogen, upper trace) conditions. Data is taken in the far field at a single point in the film under constant optical excitation at 488 nm.
sity over time with the probe in contact (shear force range) and slightly out of contact with the sample surface. With the probe withdrawn, the total PL intensity remains over 97% for over two minutes, similar to that seen in the far field. However, with shear-force feedback turned on, the situation is quite different with a 25% drop in intensity during the first 120 seconds. This drop is much more than would be expected from far field (Fig. 5) measurements.

The extreme dependence of this effect on the probe-sample separation, suggests that in addition to photobleaching, another mechanism may be contributing to the decrease in PL intensity — either heat induced (due to the high light intensity near fiber tip) or mechanical resulting from the shear force interaction between tip and sample.

Fig. 7 (taken after recording Fig. 6) provides an insight into a possible mechanism. This figure shows that not only has PL intensity been reduced at point were the local PL spectra were taken (Fig. 7(b)) from ~60 to ~20 but also that there has been topological damage to the film’s surface at the same point (Fig. 7(a)). In contrast to the flatness of the rest of the scan area, the region surrounding the point where the spectrum was taken have been disturbed, with a small depression forming where the tip interacted with the surface and a small hill has appearing to one side of this depression. This feature is much more consistent with the mechanical mechanism than with an optical or thermal mechanism. This interpretation was checked by moving to a different point on the film, turning the laser off to eliminate heating, while maintaining tip in shear force contact. Thirty minutes later the topographic and optical images around the point were recorded. As seen in Fig. 8(a) topographic damage is severe with a similar depression and hill. Corresponding contrast is seen in the PL image (Fig. 8(b)). The intensity drops from ~35 to ~20 units at the depression. The magnitude of the intensity drop is consistent with the view that the observed drop in signal results from mechanical displacement of the film rather than a heating mechanism.

While it is tempting to contribute this decrease in signal to the reduced film thickness (~25%) at the point in question, it is more likely the result of a reduced coupling efficiency of light as the probe passes over the depression.

Consider, for example, collection mode NSOM: As the tip scans across the surface, what one measures is not the absolute value of PL emitted from the sample but rather the fraction collected by the tip. The latter is a convolution of the emitted light and a spatially dependent coupling efficiency. Above small mechanical depressions, this coupling efficiency may be reduced, resulting in a reduction in collected

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**Fig. 6.** Comparison of the time evolution of PL intensity with probe in contact and probe withdrawn slightly out of shear-force feedback range. Data is taken under low pressure (~10 mTorr nitrogen) conditions at a single point in the film under constant optical excitation at 488 nm.

**Fig. 7.** Topographic (a) and optical (b) image after taking the PL at one point (A in Fig. 4(a)) for 15 minutes. The scale bar in the lower right corner of the figures is 1 μm in length. Scan direction is from left to right first and from bottom to top second.

**Fig. 8.** Topographic (a) and optical image (b) recorded after the tapered fiber probe was maintained at the polymer surface under shear force feedback for 30 minutes in the absence of optical excitation. Scan direction is from left to right first and from bottom to top second.
light. The reverse is true in illumination mode. Thus we believe that the reduction in collected PL (relative to the unperturbed surface) is primarily due to a reduction in coupling efficiency as the probe passes over the depression rather than the reduction in film thickness. In any case, this suggests that mechanical displacement of the film associated with shear force feedback plays the dominate role in the decreased intensity observed.

4. Resolution

The resolution of a NSOM system is primarily dependent on the processing of the optical fibers rather than instrumentation. While the image in Fig. 7 suggests that the optical resolution of the system exceeds 100 nm, the FWHM of the feature in Fig. 7b is not sufficient to determine the exact spatial resolution due to coupling between the spatial and optical signal channels. Exact calibration of spatial resolution requires topographic flatness coupled with well defined optical contrast on the nanometer scale. In related work, using similar fibers and NSOM system operating under atmospheric conditions, we clearly achieved 100 nm resolution demonstrated using a machined 100 nm width slit.

In summary, a low pressure condition of ~ 10 mTorr (obtainable with a simple mechanical pump), is thus sufficient to eliminate photo-damage. Fluorescent optical images with high spatial and spectral resolution can thus be recorded. We note that the effect of the tip on the surface could be eliminated by reducing the spectrum acquisition time using a low dark count detector (i.e. a liquid nitrogen cooled CCD), or taking measurements in constant height mode (shear-force feedback off).

APPLICATION TO ORGANIC THIN FILM CHARACTERIZATION

1. Topography

Fig. 9(a) presents the topographic image of the film as observed using shear force microscopy taken at ~10 mTorr under dynamic vacuum. The film is topographically smooth and featureless over the 36 µm² region with the maximum height variation of 8 nm. In previous work, in films formed from toluene, condensed MEH-PPV phases having a height of 10-20 nm and diameters ranging from 20 to 1000 nm were clearly visible. (Similar features have also been observed for films formed from chlorobenzene and tetrahydrofuran.) In the film investigated here there is no evidence of any such domains. If such domains existed near the surface, they should be clearly visible given the nanometer sensitivity of the shear force mechanism under low pressure. It is possible that small domains (< 10 nm in size) may lie below the surface of the 60 nm thin films and thus not be visible.

2. Photoluminescence image

Fig. 9(b) presents the photoluminescence image of same area of the MEH-PPV thin film whose topography was shown in Fig. 9(a). The image is taken in at a pressure of 10 mTorr of nitrogen. The film exhibits a uniform and featureless optical PL image. There was no significant difference in optical images taken at the emission wavelengths of 590 nm and 630 nm. On a larger scale, similar results were obtained with a far-field confocal laser scanning system (350 nm resolution). While contrast, in the form of hot spots, has been seen in the PL images of thin films formed from toluene, the absence of any such contrast in the present work suggests that the present films are quite uniform.

3. Local (near field) photoluminescence spectra

A final method of optically characterizing the films is to look for local variations in PL spectra that would be averaged out in the far field. Such local variations allow one to identify areas of the film in which emission is dominated by single chain components or interchain components. Fig. 10 presents the local spectra at four points (taken at
points A, B, C, and D, as identified on Fig. 9(a)). Local PL spectra taken at different locations on the sample were identical not only with each other but also with conventional spectral measurements taken in the far-field. This suggests that a homogeneous distribution of optically active morphological structures exists.

4. Effect of photobleaching on PL spectrum

The stability of the local PL spectrum of our films was investigated using the same low pressure dynamic vacuum and film. Typical results are shown in Fig. 11. The local PL spectrum, integrated over a 30 second interval, is shown at 7 points in time (each separated by 2 minutes) for a continuously optically excited sample. Two things are obvious from the figure: there is a continuous decrease in integrated PL intensity over time, and there is no change in the shape of the PL spectra – even after long exposure. Previous NSOM studies of MEH-PPV in air have shown that photo-bleaching is accompanied by spectral change due to either preferential quenching of single chain vs. aggregates or longer segments vs. short segments. This is clearly not the case in the films investigated here. Taken together, the above measurements show that featureless films (in terms of topology, PL intensity, PL spectrum on the scale of 50-100 nm) of MEH-PPV can be produced using chlorobenzene as a solvent.

CONCLUSIONS

In summary, a low-cost controlled environment near-field scanning optical microscope has been developed. Operation in a nitrogen environment of a few mTorr is shown to significantly reduce photo-bleaching in environmentally sensitive organic films on the typical experimental timescale. In this paper, we have reported on the first featureless films (in terms of topology, PL intensity and PL spectrum on a ~50 nm length scale) of MEH-PPV to be produced. We believe that this type of controlled environment microscope should facilitate environment studies on response of organic thin films to oxygen and vapor in the presence of light.

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